

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SHIMAZU ET AL.	
		Examiner Javid A. Amini	Art Unit 2672	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,952,992 A	09-1999	Helms, Frank P.	345/102
	B	US-6,269,195 B1	07-2001	Gonsalves et al.	382/284
	C	US-5,764,139	06-1998	Nojima et al.	340/461
	D	US-6,094,185 A	07-2000	Shirriff, Kenneth W.	345/102
	E	US-5,847,704 A	12-1998	Hartman, Hollister A.	715/764
	F	US-6,466,235 B1	10-2002	Smith et al.	715/771
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Visual data interpretation, Joanna R. Alexander, SPIE-the international society for optical engineering, Volume 1668; pp. 61-72; 1992.
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.